KCB820 High Isolation SPDT 0.02 – 6 GHz





KCB820 is a GaAs pHEMT Non-Reflective high performance, low loss switch in a 7 lead Hermetic Surface-Mount Technology (SMT) package for Harsh Environments including Defense and Satellite application. This device can be ordered with the 100% screening requirements of MIL-PRF-38535 Class B and S, in addition to the required QCI.

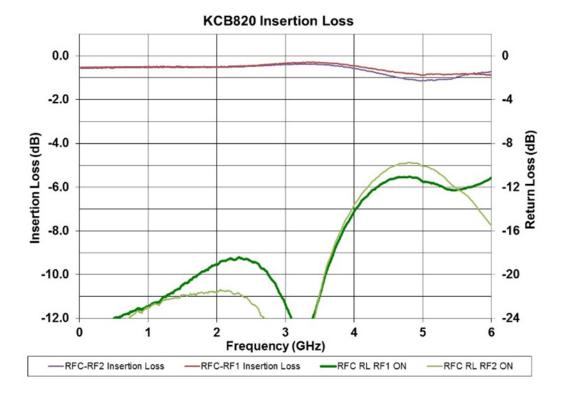
FEATURES

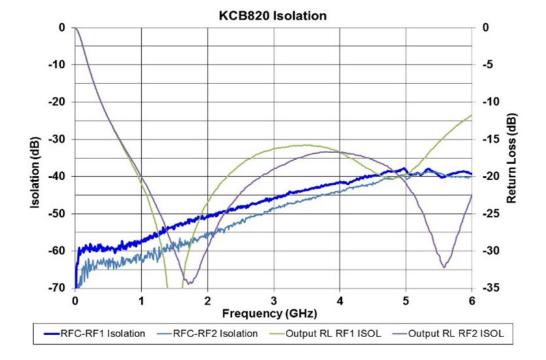
- ✓ Low Loss: .8 dB @ 2 GHz Isolation: 55 dB @ 2 GHz.
- \checkmark Non Reflective Match in off State (S22).
- √ NASA EEE-INST-002 compliant.
- ✓ Successfully Tested to 1M RAD TID.
- \checkmark High Reliability Class B and S Screening Available.
- \checkmark See Page 4 for MFR HI REL Ordering Details.

ELECTRICAL CHARACTERISTICS (+25°C)

Parameter	Conditions	Min	Typical	Max	Units
Insertion Loss	0.02 - 2.0 GHz 2.0 - 3.0 GHz 3.0 - 4.0 GHz 4.0 - 6.0 GHz		0.75 0.8 1.0 1.5	1.10 1.25 1.35 1.8	dB dB dB dB
RF1/RF2 Return Loss (ON-State)	0.02 - 2.0 GHz 19 2.0 - 3.0 GHz 15 3.0 - 4.0 GHz 12 4.0 - 6.0 GHz 9		22 22 18 12		dB dB dB dB
RF1/RF2 Return Loss (OFF-State)			0 8 11 15 15 13		dB dB dB dB dB dB
Isolation	0.02 - 2.0 GHz 2.0 - 3.0 GHz 3.0 - 4.0 GHz 4.0 - 6.0 GHz	50 50 40 35	55 55 50 45		dB dB dB dB
Input 1 dB Compression (P1dB)	Vctl = 0V/+5V, 0.5- 2.0 GHz		+30		dBm
Third Order Output Intercept Point (IP3)	+8 dBm Input Tones, 1 MHz Spacing, Vctl = 0V/5V, 0.5- 2.0 GHz		+46		dBm
Switching Speed: Rise, Fall ON/OFF	10/90% or 90/10% RF 50% CTL to 90/10% RF		5 15		nS nS
Negative (Positive) ControlDC Voltage/ctrl HighDC Voltage/ctrl LowDC VoltagectrlDC Current		-7.0 (+2.7) -0.25	-5.0 (+5.0) 0 50	-4.5 (+7.0) +0.25 200	V V uA

TYPICAL PERFORMANCE (+25°C)





Note: Typical Insertion loss change .003db /degree C. .



KCB820 | HIGH ISOLATION SPDT 0.02 - 6 GHZ

TRUTH TABLE/NEGATIVE CONTROL

Control Input		Signal Path State	
В	А	RFC to RF1	RFC to RF2
-5.0	0	ON	OFF
0	-5	OFF	ON

TRUTH TABLE/POSITIVE CONTROL

Control Input		Signal Path State	
В	А	RFC to RF1	RFC to RF2
0	+5.0	ON	OFF
+5.0	0	OFF	ON

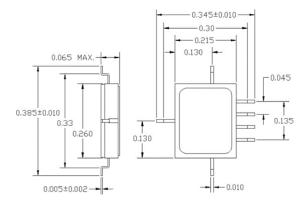
Note: External blocking capacitors are required on all RF ports for positive control operation. Capacitor should be selected to allow for low frequency operation.

ABSOLUTE MAXIMUM RATINGS

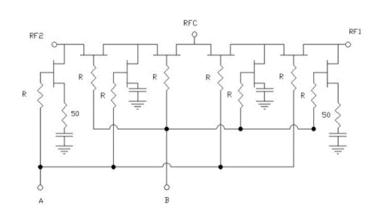
Exceeding Max limits may cause damage				
Characteristic	Min.	Max.	Units	
Control Voltage	-7.5	+7.5	Volts	
RF Input Power		+30	dBm	
Storage Temperature	-65	+150	°C	
Operating Case Temp	-55	+125	°C	
Junction Temperature		+150	°C	
Operating Frequency	0.03	6.00	GHz	

OUTLINE DRAWING

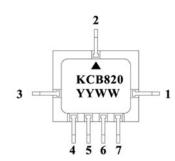
Dimensions are shown in inches.



SCHEMATIC



PINOUT



1	RF 2	
2	RF C	
3	RF 1	
4	GND	
5	Α	
6	В	
7	GND	

XXX = Serial number will be added for Class B and S Part numbers



Caution: Class 1A (HBM 250V) Electrostatic Sensitive Device. Proper ESD precaution should be used when handling device.



MFR HI-REL SCREENING FLOW

Test Inspection	MIL – STD -883		Requirement	
	Method	Condition	Class B	Class S
Wafer Lot Acceptance /1	5007		N/A	Per Wafer Lot
Non-Destructive Bond Pull	2023		SPC	SPC
Internal Visual	2010	A= Class S, B = Class B	100%	100%
Temperature Cycle	1010	С	100%	100%
Acceleration	2001	E (Y1 only)	100%	100%
PIND	2020	A (5 Cycles)	N/A	100%
Serialization	Per Product Specification		100%	100%
Radiographic	2012	2 views	N/A	100%
Electrical Test	Small Signal Testing	+25 ⁰ C	100%	100%
Burn In	1015	А	100%/160 Hours/125 ⁰ C	100%/240 Hours/125 ^o C
Final Electrical	Small Signal Testing	+25 ⁰ C	100%	100%
PDA Calculation	5004	+/- 0.25 dB IL +/- 100% ∆ Icc or +/- 60uA whichever is greater	5%	5%/3% functional
Group A Electrical/5	Per Product Specification	-55 ⁰ C + 125 ⁰ C	45/0	45/0
Leak Test	1014 A and C	1 x 10 -8 Max	100%	100%
External Visual	2009		100%	100%

NOTES

- 1. Product under configuration control per KCB QAP 015.
- 2. Customer will be notified of all class 1 changes for Class B and S part numbers.
- 3. Wafer Lot Acceptance will include 100% die visual, SEM analysis and Lot Traceability.
- 4. Electrical Test Data will be recorded for each serial number and included in Final Test Report for all Class S part numbers.
- 5. Group A Electrical testing will include the Small Signal and Ic at the Min/Max operating condition. The Dynamic test (P1dB, IP3, SS) will be tested at +25c only.

ORDERING INFORMATION

	Unscreened	Class B	Class S
KCB Solutions Part Number	KCB820C	KCB820B	KCB820S

